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## \*BIBDATASHEET\*

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CONFIRMATION NO. 6009

SERIAL NUMBER 10/685,542	FILING DATE 10/16/2003	CLASS 324	GROUP ART UNIT 2829	ATTORNEY DOCKET NO. 990250B
	RULE			

## APPLICANTS

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## \*\* CONTINUING DATA \*\*\*\*\*

This application is a DIV of 09/828,221 04/09/2001 PAT 6,661,247

which is a DIV of 09/268,338 03/16/1999 PAT 6,249,135

which is a CIP of 09/009,261 01/20/1998 ABN

## \*\* FOREIGN APPLICATIONS \*\*\*\*\*

JAPAN 9-255786 09/19/1997

JAPAN 10-263579 09/17/1998

## IF REQUIRED, FOREIGN FILING LICENSE GRANTED

\*\* 01/20/2004

Foreign Priority claimed 35 USC 119 (a-d) conditions met	<input checked="" type="checkbox"/> yes <input type="checkbox"/> no  <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance	STATE OR COUNTRY JAPAN	SHEETS DRAWING 32	TOTAL CLAIMS 14	INDEPENDENT CLAIMS 10
Verified and Acknowledged   Examiner's Signature	Initials				

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## TITLE

Semiconductor testing device

FILING FEE	FEES: Authority has been given in Paper	<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees ( Filing ) <input type="checkbox"/> 1.17 Fees ( Processing Ext. of time )
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